

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/506,440	<b>Applicant(s)/Patent under Reexamination</b> MAEDA, YOICHI
	<b>Examiner</b> Quan-Zhen Wang	<b>Art Unit</b> 2613

**SEARCHED**

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner